


<b>Search Notes</b>  	<b>Application/Control No.</b>  10589680	<b>Applicant(s)/Patent Under Reexamination</b>  NAKABAYASHI ET AL.
	<b>Examiner</b>  JONATHAN C LANGMAN	<b>Art Unit</b>  1794

### SEARCHED

Class	Subclass	Date	Examiner
117	951	5/6/2010	JCL
428	446,698	5/6/2010	JCL
501	88	5/6/2010	JCL

### SEARCH NOTES

Search Notes	Date	Examiner
East Text Search, Palm Inventor Search	4/8/2009	JCL
Updated East Text Search, Non Patent Literature Search keywords: uncompensated sic, vanadium resistivity	11/25/2009	JCL
Updated East Text Search, non Patent Literature Search: keywords: residual, uncompensated, background neutral donors or impurities; net shallow impurity concentration; vanadium; resistivity; Palm Inventor Search	5/6/2010	JCL

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
117	951	5/6/2010	JCL
428	446,698	5/6/2010	JCL
501	88	5/6/2010	JCL

--	--